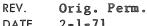
NO. 8-0550



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TEST SPECIFICATIONS FOR TYPE T4533 SERIES CATHODE RAY TUBE

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All the given specifications refer to the following test voltages (measured with respect to cathode).

Electrode	Pin Number	Voltages
Post-accelerator		14,000 VDC ± 2%
Lower helix) Isolation shield)	12	1,840 VDC ± 1%
D3 D4 Shield Accelerator Electrod) 7 e)	2,000 VDC ± 1%
Post accelerator gri	d 10	1,960 VDC ± 1%
DlD2 Shield	9	1,975 to 2,050 VDC*
Average of Deflectio	n) D1 D2) D3 D4	2,025 VDC ± 1% 2,000 VDC ± 1%
Astigmatism electrod	e 5	1,985 to 2,060 VDC**
Focusing electrode	4	180 to 450 VDC**
Heater voltage	1,14	6.3 VAC ± 3% R.M.S.

^{*} Recommended range. Adjust for best geometry.

For test procedures, see P.S.8-0595.

CAUTION: AT NO TIME SHOULD CATHODE CURRENT EXCEED 1.5 mA.

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^{**} Recommended range. Adjust for best overall focus.

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Test Characteristics	P.S. 8-0595 Step	Conditions	Specification Limit
Helix current	2.0		40μA maximum 2μA minimum
Phosphor defects and opaque spots from frame grid defects	3.0		See P.S.8-0598
Gun-graticule align- ment. Grat: Internal fixed	4.3	Align trace on left side of graticule. NOTE: align-ment is to be maintained during following steps.	+ 2.7 degrees († 2.25 minor division)
Trace alignment	4.3		
High-voltage connect- ion to screen	4.4		See P.S.8-0595
Cathode interface	4.5 & 20.1.2		See P.S. 8-0595
H-K leakage	4.6 & 20.1.2		See P.S. 8-0595
Trace orthogonality	6.1		\pm 1.5 $^{\circ}$ (1.0 minor divisions
Geometry	6.2	With a normal 8 x 10 division square raster or time markers.	Maximum deviation from straight line. Horiz: 0.5 minor division.
Horizontal resolution	6.3	Resolution is checked with time mark generator set at 100 μs and time/sweep switch at 5.0 ms. I _b = 2μA	150 markers visible in 10 major divisions. No dis- torted lines visible in 10 major divisions.
Spot centering	7.1	Horizontal	Within [†] 0.5 major divisions from geometric center.
		Vertical	Within ± 0.5 major divisions of geometric center.
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	2 0 0505		
Test	P.S. 8-0595	1	Consideration limit
Characteristics	Step	Conditions	Specification Limit
D3 D4 scan (vertical)	8.1	At 8 divisions scan, max- imum bean interception per plate. $I_b = 10 \mu A$	
D1 D2 scan (horizontal	8.2	At 10 division scan, maximum beam interception per pl I $_{ m b}$ = 10 μA	50% ate
D3 D4 deflection factor (vertical)	9.1	At optimum geometry and fixed shield voltage. Range meter setting = 50	3.2 - 3.7 V/division (25.6 - 29.6 V/scan)
D1 D2 deflection factor (horizontal)	9.2	At optimum geometry and shield voltage at average plate. Range meter setting = 100	10.2 - 11.8 V/division (102 - 118 V/scan)
Grid #1 cutoff	10.0	Visual extinction of unde- flected focused spot (unblanking off)	75 - 105 V
Cathode current	11.0	With grid #1 drive of 50 V from cutoff, use following table:	
		v_{co} (85% of K = 3.2)	I _k
		75 - 80 81 - 85 86 - 90 91 - 95 96 -100 101 -105	.48 mA minimum .43 " " .40 " " .37 " " .34 " " .32 " "
Beam current	12.0	With a small display approximately 2×2 divisions to avoid current interception by the deflection plates and erroneous reading of I_k = 0.5 mA.	I _b ≥ 20 μA
Linearity	14.0	Maximum (with 2 horizontal lines 2 major divisions apart vertically.)	0.5 minor divisions
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Test Characteristics	P.S.5-0595 Step	Conditions	Specification Limit
Burrs Helix flare (use hood) Gun flare Grid emission Vertical trace width	15.0 16.0 16.0 17.0 18.0	Signal - 1 kHz square wave (triggered). Amplitude - 2 major divisions. Time/sweep switch at 5.0 ms I = 2 \(\text{µA} \) 8 x 10 div.	See P.S.8-0595 See P.S.8-0595 See P.S.8-0595 Area A = .040" maximum Area B = .050" maximum
Rod charge After test phosphor check D1 D2 effective capacitance D3 D4 effective capacitance	19.1 20.1.3	Measure on QA sample <u>only</u> . Measure on QA sample <u>only</u> .	See P.S.8-0595 See P.S.8-0595 9.8 μμF maximum 6.8 μμF maximum